

Vishay Siliconix

P-Channel 20-V (D-S) MOSFET

| PRODUCT SUMMARY | | | | |
|---------------------|------------------------------------|--------------------|-----------------------|--|
| V _{DS} (V) | $R_{DS(on)}(\Omega)$ | I _D (A) | Q _g (Typ.) | |
| | 0.018 at V _{GS} = - 4.5 V | - 12 ^a | | |
| - 20 | 0.026 at V _{GS} = - 2.5 V | - 12 ^a | 20 nC | |
| | 0.065 at V _{GS} = - 1.8 V | - 4 | | |

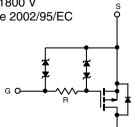
PowerPAK SC-70-6L-Single

FEATURES

- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET® Power MOSFET
- New Thermally Enhanced PowerPAK® SC-70 Package
 - Small Footprint Area
 - Low On-Resistance
- 100 % $\rm R_{\rm g}$ Tested Built in ESD Protection with Zener Diode
- Typical ESD Performance: 1800 V
- Compliant to RoHS Directive 2002/95/EC

APPLICATIONS

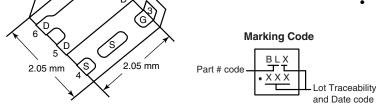
- Portable Devices
 - Load Switch
 - Battery Switch
 - Charger Switch



P-Channel MOSFET

HALOGEN

FREE



Ordering Information: SiA433EDJ-T1-GE3 (Lead (Pb)-free and Halogen-free)

| Parameter | | Symbol | Limit | Unit | |
|--|-----------------------------------|-----------------|------------------------|------|--|
| Drain-Source Voltage | | V_{DS} | - 20 | V | |
| Gate-Source Voltage | | V _{GS} | ± 12 | | |
| | T _C = 25 °C | | - 12 ^a | | |
| Continuous Drain Current (T ₁ = 150 °C) | T _C = 70 °C | L . | - 12 ^a | | |
| Continuous Diain Current (1) = 130 C) | T _A = 25 °C | I _D | - 11.3 ^{b, c} | | |
| | T _A = 70 °C | | - 9.1 ^{b, c} | A | |
| Pulsed Drain Current | | I _{DM} | - 50 | | |
| Continuous Source-Drain Diode Current | T _C = 25 °C | l _a | - 12 ^a | | |
| Continuous Cource Diam Blode Current | T _A = 25 °C | I _S | - 2.9 ^{b, c} | | |
| | T _C = 25 °C | | 19 | | |
| Maximum Power Dissipation | T _C = 70 °C | P _D | 12 | w | |
| | T _A = 25 °C | ' D | 3.5 ^{b, c} | | |
| | T _A = 70 °C | | 2.2 ^{b, c} | | |
| Operating Junction and Storage Temperature R | T _J , T _{stg} | - 55 to 150 | ာင | | |
| Soldering Recommendations (Peak Temperature) ^{d, e} | | | 260 | | |

| THERMAL RESISTANCE RATINGS | | | | | | |
|---|--------------|-------------------|---------|---------|------|--|
| Parameter | | Symbol | Typical | Maximum | Unit | |
| Maximum Junction-to-Ambient ^{b, f} | t ≤ 5 s | R _{thJA} | 28 | 36 | °C/W | |
| Maximum Junction-to-Case (Drain) | Steady State | R _{thJC} | 5.3 | 6.5 |] | |

Notes:

- a. Package limited.
- b. Surface Mounted on 1" x 1" FR4 board.
- c. t = 5 s.
- d. See Solder Profile (www.vishay.com/ppg?73257). The PowerPAK SC-70 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under Steady State conditions is 80 °C/W.

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| SPECIFICATIONS T _J = 25 °C, unless otherwise noted | | | | | | | |
|--|-------------------------|--|-------|--------|-------|-------|--|
| Parameter | Symbol | Test Conditions | Min. | Тур. | Max. | Unit | |
| Static | | | | | | | |
| Drain-Source Breakdown Voltage | V _{DS} | $V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$ | - 20 | | | V | |
| V _{DS} Temperature Coefficient | $\Delta V_{DS}/T_{J}$ | I _D = - 250 μA | | - 12 | | mV/°C | |
| V _{GS(th)} Temperature Coefficient | $\Delta V_{GS(th)}/T_J$ | 10 = - 200 μΑ | | 3 | | | |
| Gate-Source Threshold Voltage | V _{GS(th)} | $V_{DS} = V_{GS}, I_{D} = -250 \mu A$ | - 0.5 | | - 1.2 | V | |
| Gate-Source Leakage | I _{GSS} | $V_{DS} = 0 \text{ V}, V_{GS} = \pm 12 \text{ V}$ | | | ± 20 | | |
| | | $V_{DS} = 0 \text{ V}, V_{GS} = \pm 4.5 \text{ V}$ | | | ± 0.5 | μΑ | |
| Zana Oata Valtana Daria Oamani | ١, | V _{DS} = - 20 V, V _{GS} = 0 V | | | - 1 | | |
| Zero Gate Voltage Drain Current | I _{DSS} | $V_{DS} = -20 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 \text{ °C}$ | | | - 10 | 1 | |
| On-State Drain Current ^a | I _{D(on)} | $V_{DS} \le -5 \text{ V}, V_{GS} = -4.5 \text{ V}$ | - 20 | | | Α | |
| | | V _{GS} = - 4.5 V, I _D = - 7.6 A | | 0.015 | 0.018 | Ω | |
| Drain-Source On-State Resistance ^a | R _{DS(on)} | V _{GS} = - 2.5 V, I _D = - 6.3 A | | 0.021 | 0.026 | | |
| | | V _{GS} = - 1.8 V, I _D = - 2.5 A | | 0.040 | 0.065 | | |
| Forward Transconductance ^a | 9 _{fs} | V _{DS} = - 10 V, I _D = - 7.6 A | | 35 | | S | |
| Dynamic ^b | | | | I | L | I . | |
| Total Gate Charge | | V _{DS} = - 10 V, V _{GS} = - 8 V, I _D = - 11 A | | 50 | 75 | nC | |
| 0.1.0 | Q _g | V _{DS} = - 10 V, V _{GS} = - 4.5 V, I _D = - 11 A | | 20 | 30 | | |
| Gate-Source Charge | Q _{gs} | | | 3.3 | | | |
| Gate-Drain Charge | Q _{gd} | | | 8.4 | | | |
| Gate Resistance | R_{g} | f = 1 MHz | 0.2 | 1 | 2 | kΩ | |
| Turn-On Delay Time | t _{d(on)} | | | 0.71 | 1.1 | | |
| Rise Time | t _r | V_{DD} = - 10 V, R_L = 1 Ω | | 1.7 | 2.6 | - | |
| Turn-Off Delay Time | | $I_D \cong$ - 9 A, V_{GEN} = - 4.5 V, R_g = 1 Ω | | 6 | 9 | | |
| Fall Time | t _f | | | 3.2 | 5 | 1 | |
| Turn-On Delay Time | t _{d(on)} | | | 0.3 | 0.45 | us | |
| Rise Time | t _r | V_{DD} = - 10 V, R_L = 1 Ω | | 0.6 | 0.9 | 1 | |
| Turn-Off Delay Time | t _{d(off)} | $I_D \cong$ - 9 A, V_{GEN} = - 10 V, R_g = 1 Ω | | 10 | 15 | | |
| Fall Time | t _f | | | 3.5 | 5.5 | | |
| Drain-Source Body Diode Characterist | ics | | | • | l | • | |
| Continuous Source-Drain Diode Current | I _S | T _C = 25 °C | | | - 12 | А | |
| Pulse Diode Forward Current | I _{SM} | | | | - 50 | | |
| Body Diode Voltage | V_{SD} | I _S = - 9 A, V _{GS} = 0 V | | - 0.85 | - 1.2 | V | |
| Body Diode Reverse Recovery Time t _{rr} | | | | 30 | 60 | ns | |
| Body Diode Reverse Recovery Charge | Q _{rr} | I _F = 9 A, dl/dt = 100 A/μs, T _J = 25 °C | | 20 | 40 | nC | |
| Reverse Recovery Fall Time | t _a | | | 13 | | ns | |
| Reverse Recovery Rise Time | t _b | | | 17 | | | |

Notes:

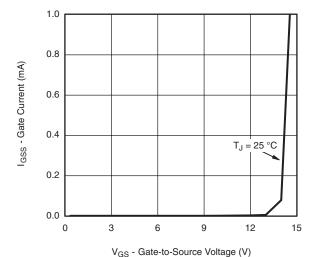
- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

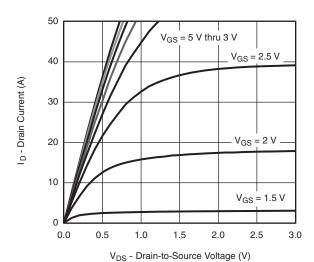


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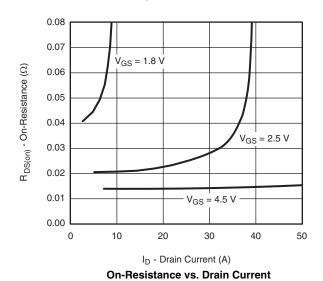
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Gate Current vs. Gate-Source Voltage

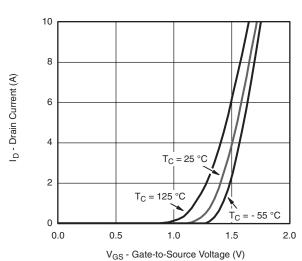


Output Characteristics

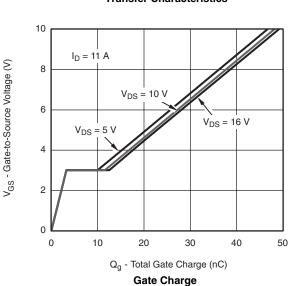


10-2 10-3 10-4 10-5 10-6 10-6 10-7 10-8 10-9 0 3 6 9 12 15 V_{GS} - Gate-to-Source Voltage (V)

Gate Current vs. Gate-Source Voltage



Transfer Characteristics

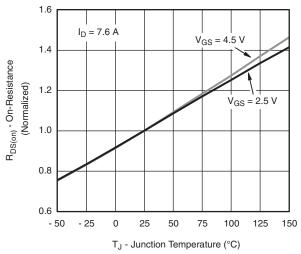


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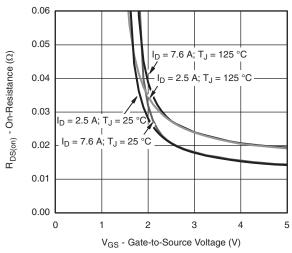
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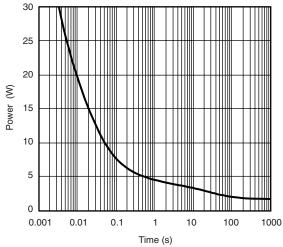
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



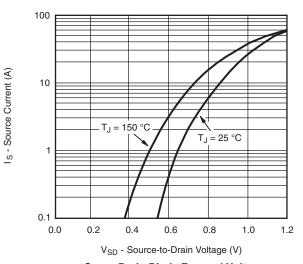
On-Resistance vs. Junction Temperature



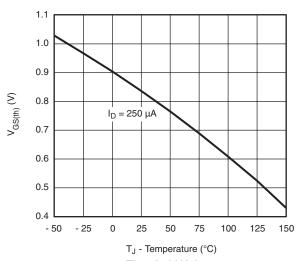
On-Resistance vs. Gate-to-Source Voltage



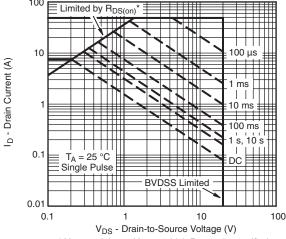
Single Pulse Power, Junction-to-Ambient



Soure-Drain Diode Forward Voltage



Threshold Voltage



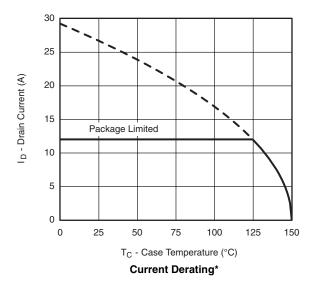
* V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

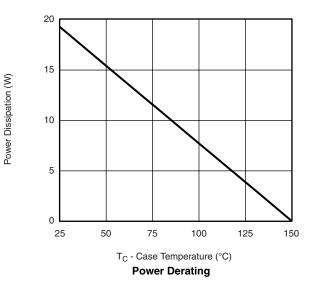
Safe Operating Area, Junction-to-Ambient



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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted





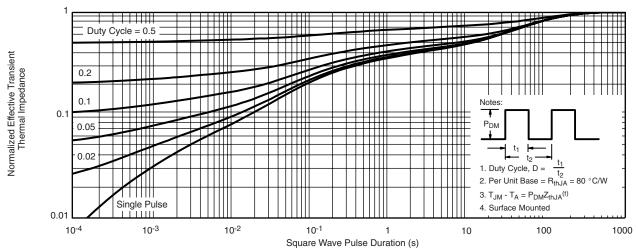
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^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

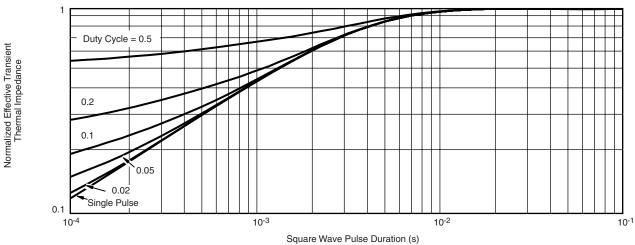
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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